Search Notes					
		ı			
		ı			
		ı			
	:	H			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/726,247	AMUNDSON ET AL.	
Examiner	Art Unit	
Le Nguyen	2174	

SEARCHED					
Class	Subclass	Date	Examiner		
-					
· ···-					
,					

INI	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
		-			

SEARCH (INCLUDING SEAF	NOTES CH STRATEG	Y)
	DATE	EXMR
updated search	7/29/2007	LVN
consulted w/Ba Huynh	7/29/2007	LVN